

BS EN 60749-29:2011



BSI Standards Publication

Semiconductor devices — Mechanical and climatic test methods

Part 29: Latch-up test

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National foreword

This British Standard is the UK implementation of EN 60749-29:2011. It is identical to IEC 60749-29:2011. It supersedes BS EN 60749-29:2003 which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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Amendments issued since publication

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